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FORM PTO-1449 (REV. 7-80)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 5005.1111	APPLICATION NO To be assigned
LIST OF PRIOR ART CITED BY APPLICANT  (Use several sheets if necessary)				APPLICANT Heinrich ULRICH et al.	
				FILING DATE Herewith	GROUP 2877 To be assigned

### U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB-CLASS	FILING DATE IF APPROPRIATE
/FLE/	A01	2003/0058530 A1	Mar. 27, 2003	Kawano 2003/0058530	359	385	10/15/08
/FLE/	A02	6,255,642 B1	Jul. 3, 2001	Cragg et al.	250	216	
/FLE/	A03	2002/0097489 A1	Jul. 25, 2002	Kawano et al.	359	388	
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	A05						
	A06						
	A07						
	A08						
	A09						
	A10						

### FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB-CLASS	TRANSLATION	YES	NO
/FLE/	A11	DE 199 02 234 A1	Feb. 24, 2000	DE-Germany			See Intl. Search Report for PCT/EP2004/052296; see English Abstract		
	A12								
	A13								
	A14								

### OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

/FLE/	A15	V. Protasenko et al.: "Enhancement and quenching of the fluorescence of single CdSe/ZnS quantum dots studied by confocal apertureless near-field scanning optical microscope"; Proceedings of SPIE Vol. 5188 Advanced Characterization Techniques for Optics, Semiconductors, and Nanotechnologies, November 2003, pp. 254-263
↓	A16	S. Kawata et al.: "Near-Field Scanning Optical Microscope with a Laser Trapped Probe"; Jpn. J. Appl. Phys. Vol. 33 (1994), Part 2, No. 12A, 1 December 1994, pp. L 1725-L 1727
/FLE/	A17	International Search Report for PCT/EP2004/052296 (3 pages)
	A18	
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EXAMINER	/F. L. Evans/	DATE CONSIDERED	03/07/2008
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\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.